L Number	Hits	Search Text	DB	Time stamp
1	0	(gate adj array) and (esd adj implantation)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 15:53
2	0	(gate adj array) and (esd adj diffusion)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 15:53
3	4	esd adj diffusion	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 15:55
4	52	esd adj implant	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 16:04
5	0	surge adj protection adj (implant or implantaion or diffusion or dopant)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 16:05
6	65	(esd or (electrostatic adj discharge)) adj (implant or implantaion or diffusion or dopant)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 16:19
7	1	(voltage adj protection) adj (implant or implantaion or diffusion or dopant)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 17:02
8	2	20020076876.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 17:04
9	2	6008080.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 18:18
10	2	6268256.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 18:18
-	2	5559352.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:17
-	2	20030141551.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:38
-	0	(esd adj (layer or region or film)) adj drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:40
-	0	((electro adj static adj discharge) adj (layer or region or film)) adj drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:40

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-	0	((electrostatic adj discharge) adj (layer or region or film)) adj drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:40
-	0	((breakdown adj enhanced) adj (layer or region or film)) adj drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:40
-	3	(esd adj (layer or region or film)) near drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:41
-	0	((electro adj static adj discharge) adj (layer or region or film)) near drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:41
-	0	((electrostatic adj discharge) adj (layer or region or film)) near drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:42
-	0	((breakdown adj enhanced) adj (layer or region or film)) near drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:42
-	34	(esd adj (layer or region or film)) with drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:46
-	0	((electro adj static adj discharge) adj (layer or region or film)) with drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:50
-	2	((electrostatic adj discharge) adj (layer or region or film)) with drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:47
-	2	((breakdown adj enhanced) adj (layer or region or film)) with drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:47
-	29	(esd adj (layer or region or film)) with source	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:46
-	0	((electro adj static adj discharge) adj (layer or region or film)) with source	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:47
-	3	((electrostatic adj discharge) adj (layer or region or film)) with source	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:47
-	1	((breakdown adj enhanced) adj (layer or region or film)) with source	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 18:47

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–	61	((electro adj static adj discharge) or esd or (electrostatic adj discharge) or breakdown or enhance) near2 formed near2 (source or drain)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 19:02
–	76	((breakdown or enhance) adj (layer or film or region)) and esd	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 19:03
–	79	((breakdown or enhanced) adj (layer or film or region)) and esd	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 19:04
–	877	(body adj region) and (drift)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 19:09
–	2471	(breakdown or enhanced) adj (layer or film or region)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 19:09
–	10	(reduce adj breakdown adj voltage) with drain with esd	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/07 19:56
–	35	esd adj implantation	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/12 15:52